

RoHS

COMPLIANT

# P-Channel 30-V (D-S) MOSFET

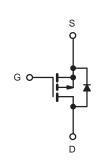
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)		
- 30	0.011 at V <sub>GS</sub> = - 10 V	- 13.5	29.5 nC		
- 30	0.015 at $V_{GS}$ = - 4.5 V	- 11.6	29.5 110		

#### **FEATURES**

- Halogen-free
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- 100 % UIS Tested

#### **APPLICATIONS**

- Load Switch
- Notebook Adaptor Switch



P-Channel MOSFET

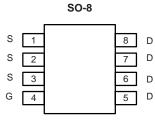
ABSOLUTE MAXIMUM RATINGS $T_A$	_ = 25 °C, unless othe	erwise noted		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	- 30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v
	T <sub>C</sub> = 25 °C		- 13.5	
Continuous Drain Current (T <sub>1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		- 11.9	
Continuous Drain Current (1) = 150°C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 10.9 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		- 8.6 <sup>a, b</sup>	Α
Pulsed Drain Current	I <sub>DM</sub>	- 50	A	
Outline Output Date Distance	T <sub>C</sub> = 25 °C	1	- 4.1	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is –	- 2.2 <sup>a, b</sup>	
Avalanche Current		I <sub>AS</sub>	- 20	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	20	mJ
	T <sub>C</sub> = 25 °C		5.0	
Maximum Dawar Dissinction	T <sub>C</sub> = 70 °C	D_	3.2	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.7 <sup>a, b</sup>	vv
	T <sub>A</sub> = 70 °C	1	1.7 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	R <sub>thJA</sub>	38	46	°C/W	
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	20	25	0/11	

Notes:

b. t = 10 s.

- c. Maximum under Steady State conditions is 85  $^{\circ}\text{C/W}.$
- d. Based on T<sub>C</sub> = 25 °C.



Top View

a. Surface mounted on 1" x 1" FR4 board.



SPECIFICATIONS T <sub>J</sub> = 25 °C, unless otherwise noted   Parameter Symbol Test Conditions Min. Typ. Max. Un						
Static	Symbol	lest conditions	wiin.	Тур.	wax.	Unit
	V <sub>DS</sub>	$V_{22} = 0 V_{12} = -250 \mu 0$	- 30			V
Drain-Source Breakdown Voltage V <sub>DS</sub> Temperature Coefficient	VDS ∆V <sub>DS</sub> /TJ	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA		24		
-		I <sub>D</sub> = - 250 μA		- 34		mV/ °C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			5.3	0.5	-
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = -250 \mu A$	- 1.4		- 2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 1 - 5	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge$ - 10 V, $V_{GS}$ = - 10 V	- 30			Α
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 10 A		0.011		Ω
		$V_{GS} = -4.5 \text{ V}, I_D = -8 \text{ A}$		0.015		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 10 A		28		S
Dynamic <sup>b</sup>						1
Input Capacitance	C <sub>iss</sub>			2550		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = -15 V$ , $V_{GS} = 0 V$ , f = 1 MHz		455		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			390		
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 10 A		57	86	nC
Gate-Source Charge	Q <sub>qs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		29.5 8	45	
Gate-Drain Charge	Q <sub>gd</sub>	$v_{\rm DS} = 10$ V, $v_{\rm GS} = 10$ V, $D = 10$ V		22		-
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.5	2.2	4.4	Ω
Turn-On Delay Time			0.0	13	25	22
Rise Time	t <sub>d(on)</sub> t <sub>r</sub>	V <sub>DD</sub> = - 15 V, R <sub>I</sub> = 1.5 Ω		10	24	-
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -10$ A, $V_{GEN} = -10$ V, $R_a = 1 \Omega$		40	70	
Fall Time	-u(011)			9	18	
Turn-On Delay Time	t <sub>d(on)</sub>			48	80	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -15 V, R_1 = 1.5 \Omega$		92	160	-
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -10 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V}, \text{ R}_{\text{a}} = 1 \Omega$		34	60	
Fall Time	t <sub>f</sub>	B S GEN S g		19	35	-
Drain-Source Body Diode Characteris	· · ·					1
Continous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 4.1	
Pulse Diode Forward Current	I <sub>SM</sub>	6			- 60	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 3 A, V <sub>GS</sub> = 0 V		- 0.75	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			27	45	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			16	27	nC
Reverse Recovery Fall Time	ta	I <sub>F</sub> = - 10 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C		12		
Reverse Recovery Rise Time	t <sub>b</sub>			15		ns

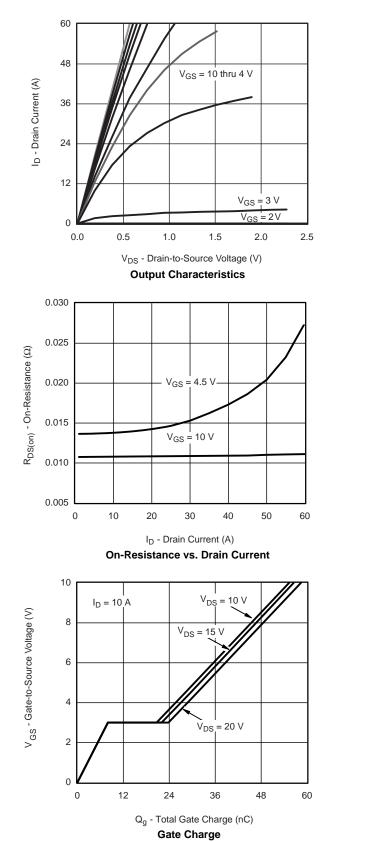
Notes:

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

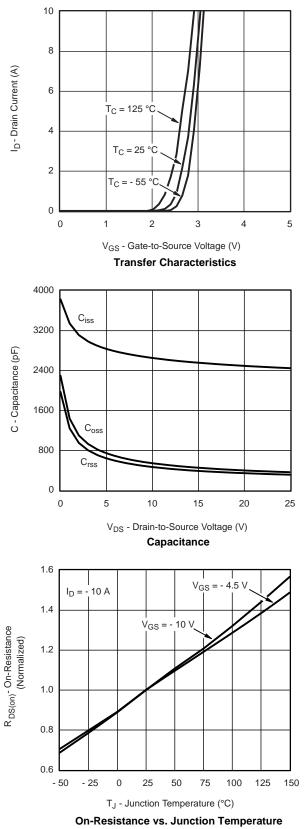
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



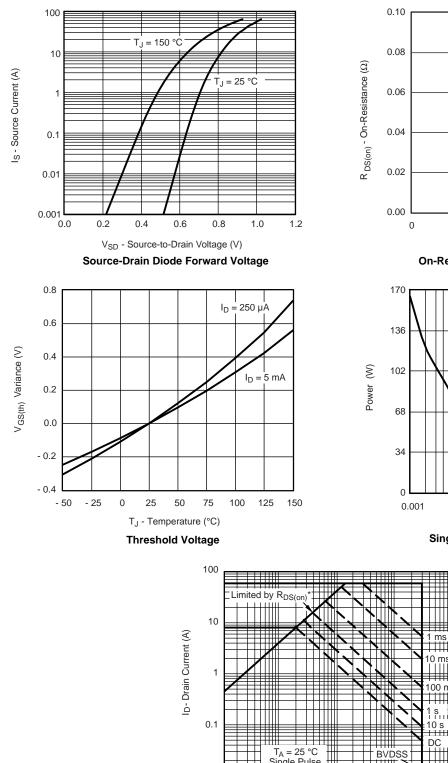


#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

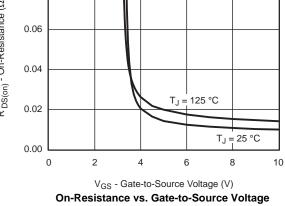


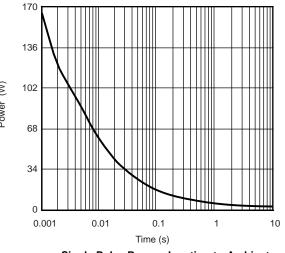


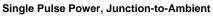
I<sub>D</sub> = 10 A

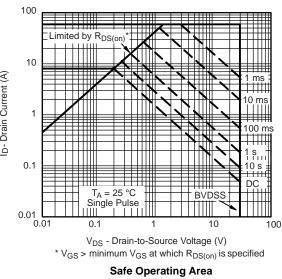


## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



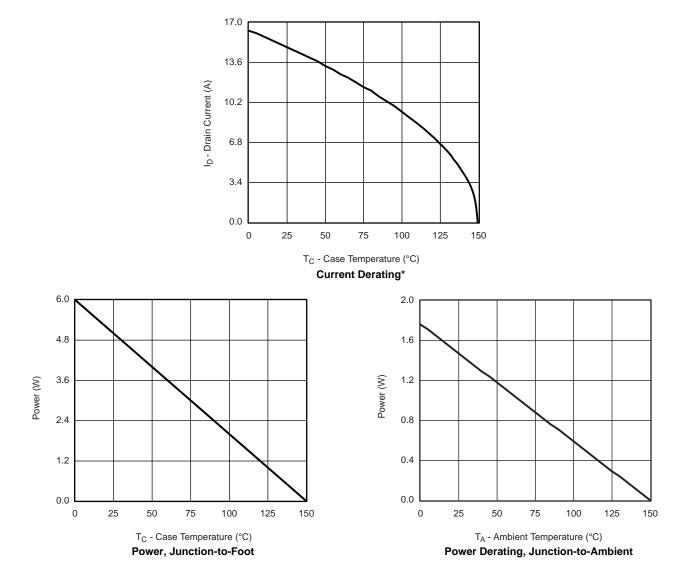








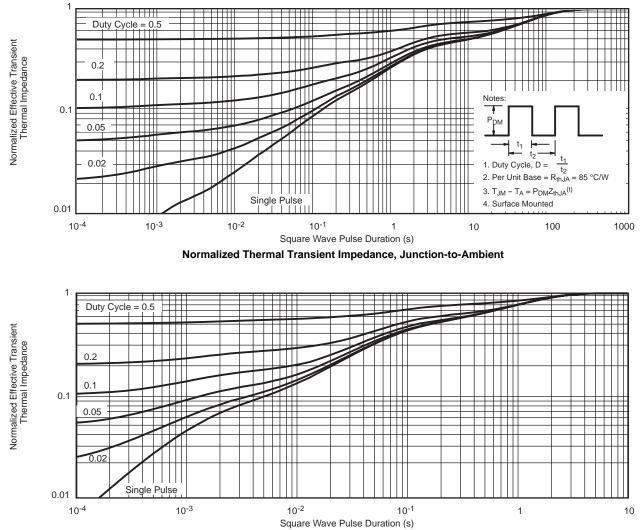
## MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.







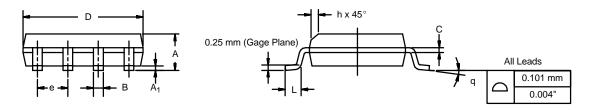
Normalized Thermal Transient Impedance, Junction-to-Foot



## SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012





	MILLIMETERS		INC	HES		
DIM	Min	Мах	Min	Max		
A	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27	1.27 BSC		0.050 BSC		
н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498						



**RECOMMENDED MINIMUM PADS FOR SO-8** 



Recommended Minimum Pads Dimensions in Inches/(mm)



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